

CRST033N08N,CRSS031N08N

SkyMOS1 N-MOSFET 85V, $2.5m\Omega$, 160A

Features

- Uses CRM(CQ) advanced SkyMOS1 technology
- Extremely low on-resistance R_{DS(on)}
- Excellent Q_qxR_{DS(on)} product(FOM)
- Qualified according to JEDEC criteria

Product Summary

V_{DS}	85V
$R_{DS(on)}$	$2.5 m\Omega$
I_{D}	160A

Applications

- Synchronous Rectification for AC/DC Quick Charger
- Battery management
- UPS (Uninterrupible Power Supplies)

100% Avalanche Tested



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRST033N08N	-	TO-220	Tube	N/A	N/A	50pcs
CRSS031N08N	-	TO-263	Tube	N/A	N/A	50pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	85	V
Continuous drain current			
T _C = 25°C (Silicon limit)	, t	208	А
T _C = 25°C (Package limit)	I_{D}	160	
T _C = 100°C (Silicon limit)		131	
Pulsed drain current ($T_C = 25$ °C, t_p limited by T_{jmax})	${ m I_{D~pulse}}$	640	Α
Avalanche energy, single pulse (L=0.5mH, Rg=25 Ω) ^[1]	E _{AS}	400	mJ
Gate-Source voltage	V_{GS}	±20	V
Power dissipation ($T_C = 25^{\circ}C$)	P _{tot}	227	W
Operating junction and storage temperature	T_j , T_{stg}	-55+150	°C

Notes:1.EAS was tested at Tj = 25° C, ID = 40A.





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Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	0.55	9C ()M
Thermal resistance, junction – ambient(min. footprint)	R _{thJA}	62	°C/W

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Cymhol	Value			Unit	Test Condition	
<u> </u>	Symbol	min.	typ.	max.	Unit	rest condition	
Static Characteristic							
Drain-source breakdown voltage	BV _{DSS}	85	-	-	V	V _{GS} =0V, I _D =250uA	
Gate threshold voltage	V _{GS(th)}	2.2	3	3.8	V	$V_{DS}=V_{GS}$, $I_{D}=250$ uA	
Zero gate voltage drain current	I_{DSS}	-	0.05 -	1 10	μА	V_{DS} =80V, V_{GS} =0V T_{j} =25°C T_{j} =125°C	
Gate-source leakage current	I_{GSS}	-	±10	±100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$	
Drain-source on-state resistance	R _{DS(on)}	-	2.5 2.3	3.0 2.8	mΩ	V _{GS} =10V, I _D =80A TO-220 TO-263	
Transconductance	g _{fs}	-	144	_	S	V_{DS} =5 V , I_{D} =80 A	

Dynamic Characteristic

Input Capacitance	C _{iss}	-	8930	-	pF		
Output Capacitance	C _{oss}	-	1746	-		V_{GS} =0V, V_{DS} =40V, f=1MHz	
Reverse Transfer Capacitance	C _{rss}	-	81	-			
Gate Total Charge	Q_{G}	-	130	-			
Gate-Source charge	Q_{gs}	-	44	-	nC	V_{GS} =10V, V_{DS} =40V, I_{D} =80A, f=1MHz	
Gate-Drain charge	Q_{gd}	-	30	-			
Turn-on delay time	t _{d(on)}	-	30	-		$V_{GS} = 10V, V_{DD} = 40V,$ $R_{G_{ext}} = 3.0\Omega$	
Rise time	t _r	-	108	-	20		
Turn-off delay time	t _{d(off)}	-	85	-	ns		
Fall time	t _f	-	120	-			
Gate resistance	R_G	-	2.1	-	Ω	V_{GS} =0V, V_{DS} =0V, f =1MHz	





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Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
	Symbol	min.	typ.	max.	Oilit	rest condition
Body Diode Forward Voltage	V_{SD}	-	0.93	1.4	V	V _{GS} =0V,I _{SD} =80A
Body Diode Reverse Recovery Time	t _{rr}	-	84	-	ns	I _F =80A, dI/dt=100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	-	226	-	nC	



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Typical Performance Characteristics

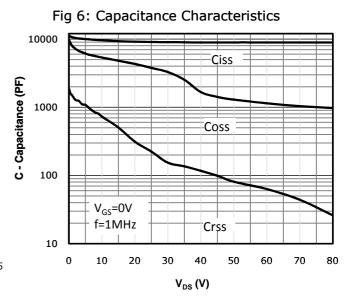
Fig 1: Output Characteristics 400 360 320 6.5V 280 240 € ²⁴⁰ 5.5V 160 120 80 4.5V 40 ² V_{DS} (V) 0 1 3 4 5

Fig 2: Transfer Characteristics 350 $V_{DS}=5V$ 300 250 **€** 200 150 100 25°C 125°C 50 0 2 0 1 5 6 7 $V_{GS}(V)$

3: Rds(on) vs Drain Current and Gate Voltage 4.0 3.5 $V_{GS}=10V$ 3.0 2.5 2.0 1.5 1.0 0.5 0.0 0 20 40 60 80 100 120 140 160 $I_D(A)$

Fig 4: Rds(on) vs Gate Voltage 12 $I_D = 80A$ 10 R_{DS(on)} (mΩ) 8 6 125°C 4 2 25°C 0 6 V_{GS} (V) 3 4 5 8 9 10

Fig 5: Rds(on) vs. Temperature 2.4 I_D=80A 2.2 R_{DS(on)}_Normalized 2.0 1.8 $V_{GS}=10V$ 1.6 1.4 1.2 1.0 0.8 50 100 175 Tj - Junction Temperature (°C)





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Fig 7: Gate Charge Characteristics

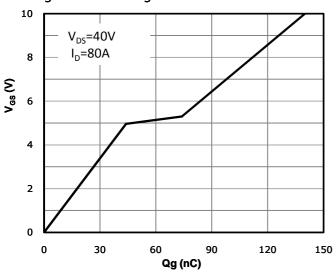


Fig 8: Body-diode Forward Characteristics

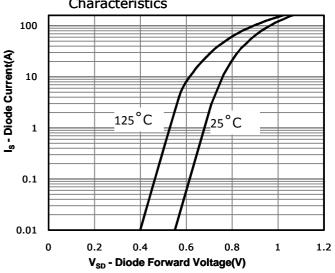


Fig 9: Power Dissipation

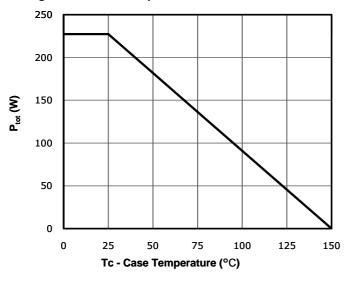


Fig 10: Drain Current Derating

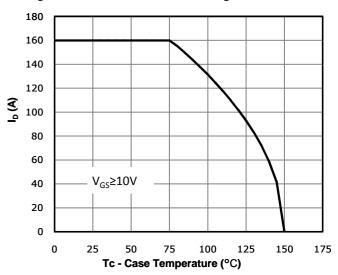
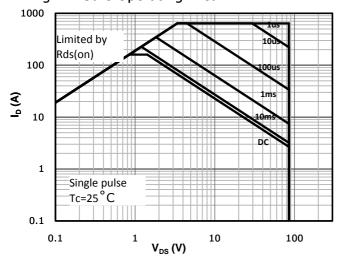


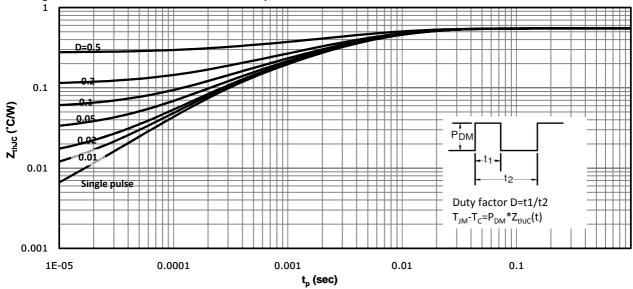
Fig 11: Safe Operating Area





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Fig 12: Max. Transient Thermal Impedance

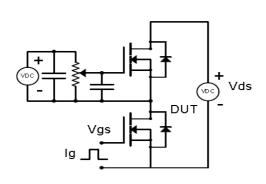


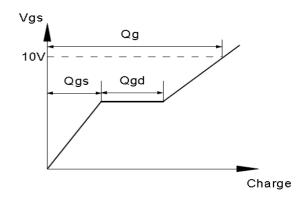


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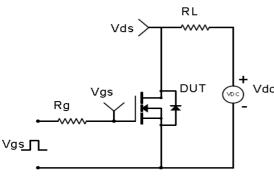
Test Circuit & Waveform

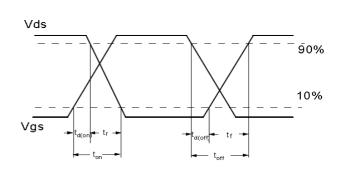
Gate Charge Test Circuit & Waveform



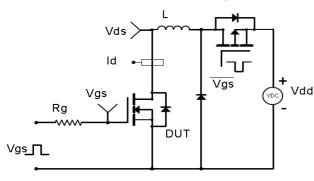


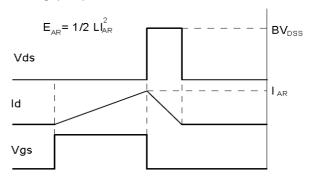
Resistive Switching Test Circuit & Waveforms



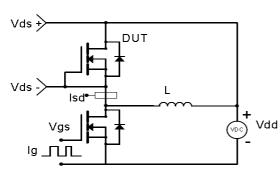


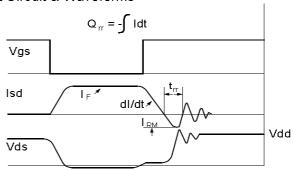
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

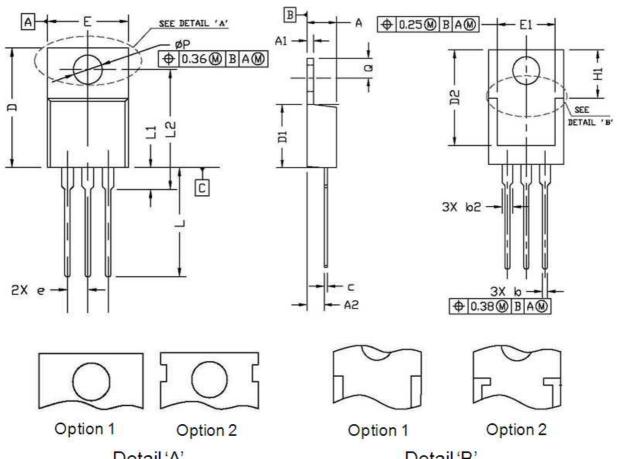






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Package Outline: TO-220-3L



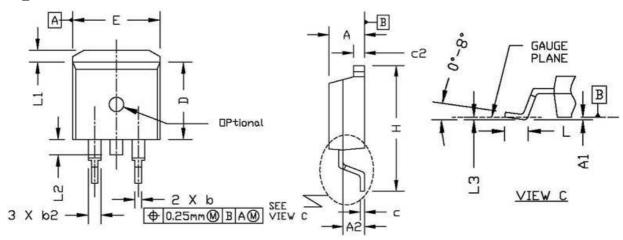
Detail 'A' Detail 'B'

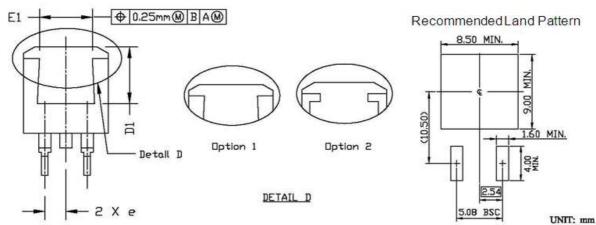
Comphal	Dimensions I	n Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.30	4.80	0.169	0.189
A1	1.20	1.45	0.047	0.057
A2	2.20	2.90	0.087	0.114
b	0.69	0.95	0.027	0.037
b2	1.00	1.60	0.039	0.063
С	0.33	0.65	0.013	0.026
D	14.70	16.20	0.579	0.638
D1	8.59	9.65	0.338	0.380
D2	11.75	13.60	0.463	0.535
е	2.54 BSC.		0.100	BSC.
Е	9.60	10.60	0.378	0.417
E1	7.00	8.46	0.276	0.333
H1	6.20	7.00	0.244	0.276
L	12.60	14.80	0.496	0.583
L1	2.70	3.80	0.106	0.150
L2	12.13	16.50	0.478	0.650
Q	2.40	3.10	0.094	0.122
Р	3.50	3.90	0.138	0.154



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Package Outline: TO-263





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Symbol	Dimensions I	n Millimeters	Dimensions	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.30	4.86	0.169	0.191
A1	0.00	0.25	0.000	0.010
A2	2.34	2.79	0.092	0.110
b	0.68	0.94	0.027	0.037
b2	1.15	1.35	0.045	0.053
С	0.33	0.65	0.013	0.026
c2	1.17	1.40	0.046	0.055
D	8.38	9.45	0.330	0.372
D1	6.90	8.17	0.272	0.322
е	2.54 BSC.		0.100 BSC.	
Е	9.78	10.50	0.385	0.413
E1	6.50	8.60	0.256	0.339
Н	14.61	15.88	0.575	0.625
L	2.24	3.00	0.088	0.118
L1	0.70	1.60	0.028	0.063
L2	1.00	1.78	0.039	0.070
L3	0.00	0.25	0.000	0.010





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Revision History

Revison	Date	Major changes
1.0	2018-09-13	Release of formal version.
2.0	2018-12-17	Add TO-263 information
3.0	2019-05-27	Supplement package outline info.

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.

